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Kind regards,

Team Nexperia



PBSS4160U

60 V, 1 A NPN low V_{CEsat} (BISS) transistor Rev. 03 — 11 December 2009

Product data sheet

Product profile

1.1 General description

NPN low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT323 (SC-70) Surface Mounted Device (SMD) plastic package.

PNP complement: PBSS5160U.

1.2 Features

- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability: I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- High voltage DC-to-DC conversion
- High voltage MOSFET gate driving
- High voltage motor control
- High voltage power switches (e.g. motors, fans)
- Automotive applications

1.4 Quick reference data

Quick reference data Table 1.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	60	V
I _C	collector current (DC)		[1] -	-	1	Α
I _{CM}	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-	2	Α
R _{CEsat}	collector-emitter saturation resistance	$I_C = 1 \text{ A}; I_B = 100 \text{ mA}$	[2] -	230	280	mΩ

^[1] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



^[2] Pulse test: $t_0 \le 300 \ \mu s$; $\delta \le 0.02$.

2. Pinning information

Table 2. Pinning

	3	
Pin	Description	Simplified outline Symbol
1	base	
2	emitter	3
3	collector	1 - 2
		sym021

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PBSS4160U	SC-70	plastic surface mounted package; 3 leads	SOT323

4. Marking

Table 4. Marking codes

Type number	Marking code ^[1]
PBSS4160U	52*

[1] * = -: made in Hong Kong

* = p: made in Hong Kong

* = t: made in Malaysia

* = W: made in China

2 of 14

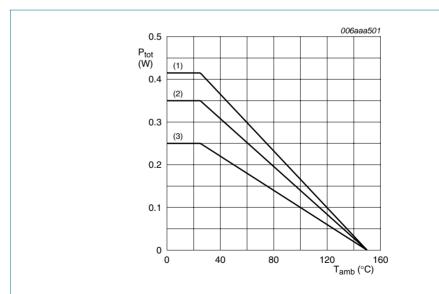
5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

		* * *	<u> </u>		
Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	80	V
V_{CEO}	collector-emitter voltage	open base	-	60	V
V_{EBO}	emitter-base voltage	open collector	-	5	V
I _C	collector current (DC)		[1] -	750	mA
			[2] _	930	mA
			[3] _	1	Α
I _{CM}	peak collector current	single pulse; $t_p \le 1$ ms	-	2	Α
I _B	base current (DC)		-	300	mA
I _{BM}	peak base current	single pulse; $t_p \le 1$ ms	-	1	Α
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$	[1] -	250	mW
			[2] _	350	mW
			[3]	415	mW
T _j	junction temperature		-	150	°C
T _{amb}	ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².
- [3] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



- (1) Ceramic PCB, Al₂O₃, standard footprint
- (2) FR4 PCB, mounting pad for collector 1 cm^2
- (3) FR4 PCB, standard footprint

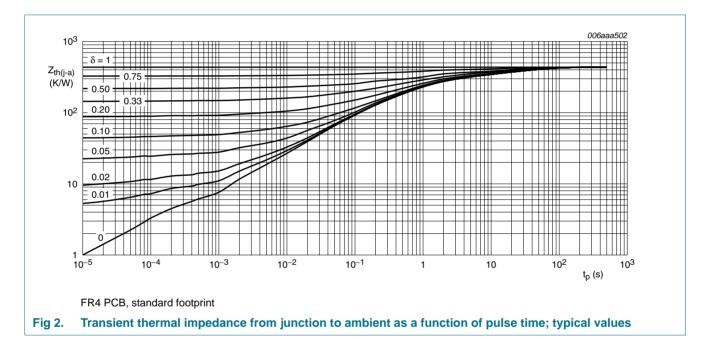
Fig 1. Power derating curves

6. Thermal characteristics

Table 6. Thermal characteristics

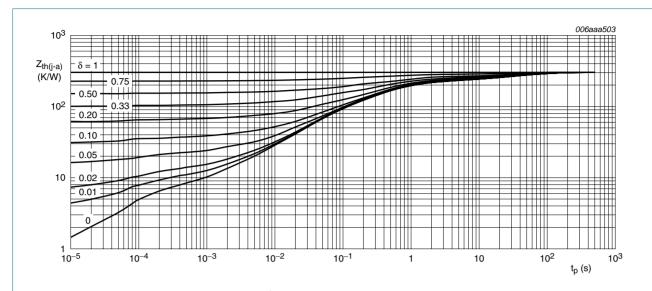
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	<u>[1]</u> -	-	500	K/W
			[2] _	-	357	K/W
			<u>[3]</u> _	-	301	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	150	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².
- [3] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



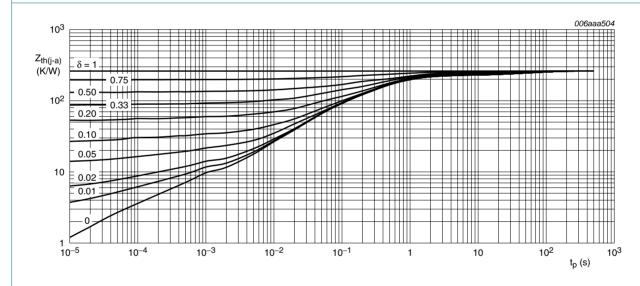
NXP Semiconductors PBSS4160U

60 V, 1 A NPN low V_{CEsat} (BISS) transistor



FR4 PCB, mounting pad for collector 1 cm²

Fig 3. Transient thermal impedance from junction to ambient as a function of pulse time; typical values



Ceramic PCB, Al₂O₃, standard footprint

Fig 4. Transient thermal impedance from junction to ambient as a function of pulse time; typical values

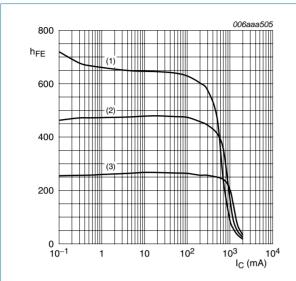
7. Characteristics

Table 7. Characteristics

 $T_{amb} = 25 \, ^{\circ}\text{C}$ unless otherwise specified.

Cumbal	Darameter	Canditions	Mir	Tim	Max	l lmit
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = 60 \text{ V}; I_E = 0 \text{ A}$	-	-	100	nA
	current	$V_{CB} = 60 \text{ V; } I_E = 0 \text{ A;}$ $T_j = 150 \text{ °C}$	-	-	50	μА
I _{CES}	collector-emitter cut-off current	$V_{CE} = 60 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$	-	-	100	nA
h _{FE}	DC current gain	$V_{CE} = 5 \text{ V}; I_{C} = 1 \text{ mA}$	250	500	-	
		$V_{CE} = 5 \text{ V}; I_{C} = 500 \text{ mA}$	<u>[1]</u> 200	420	-	
		V _{CE} = 5 V; I _C = 1 A	100	180	-	
OLOGI	collector-emitter saturation	$I_C = 100 \text{ mA}; I_B = 1 \text{ mA}$	-	90	115	mV
	voltage	$I_C = 500 \text{ mA};$ $I_B = 50 \text{ mA}$	-	120	150	mV
		$I_C = 1 \text{ A}; I_B = 100 \text{ mA}$	[1] -	230	280	mV
R _{CEsat}	collector-emitter saturation resistance	$I_C = 1 \text{ A}; I_B = 100 \text{ mA}$	[1] -	230	280	mΩ
V_{BEsat}	base-emitter saturation voltage	$I_C = 1 \text{ A}; I_B = 50 \text{ mA}$	[1] -	0.95	1.1	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = 5 \text{ V}; I_{C} = 1 \text{ A}$	[1] -	0.85	0.9	V
t _d	delay time	$I_C = 0.5 A;$	-	11	-	ns
t _r	rise time	l _{Bon} = 25 mA; - l _{Boff} = −25 mA	-	78	-	ns
t _{on}	turn-on time	1Boff = -25 IIIA	-	90	-	ns
t _s	storage time		-	340	-	ns
t _f	fall time		-	160	-	ns
t _{off}	turn-off time		-	500	-	ns
f _T	transition frequency	$V_{CE} = 10 \text{ V};$ $I_{C} = 50 \text{ mA};$ f = 100 MHz	150	220	-	MHz
C _c	collector capacitance	$V_{CB} = 10 \text{ V};$ $I_E = i_e = 0 \text{ A}; f = 1 \text{ MHz}$	-	5.5	10	pF

^[1] Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$

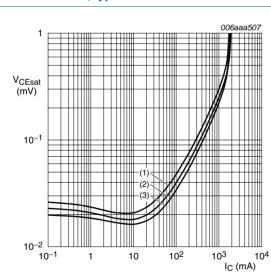


$$V_{CE} = 5 V$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 5. DC current gain as a function of collector current; typical values



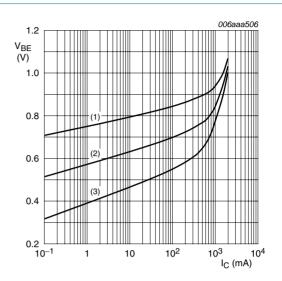
$$I_{\rm C}/I_{\rm B} = 20$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 7. Collector-emitter saturation voltage as a function of collector current; typical values



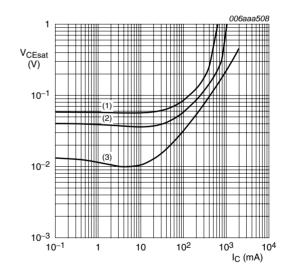
$$V_{CE} = 5 V$$

(1)
$$T_{amb} = -55 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = 100 \, ^{\circ}C$$

Fig 6. Base-emitter voltage as a function of collector current; typical values



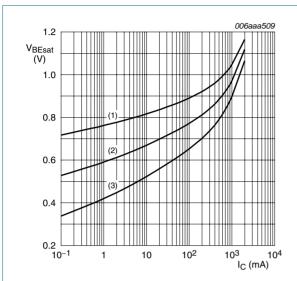
$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 100$$

(2)
$$I_C/I_B = 50$$

(3)
$$I_C/I_B = 10$$

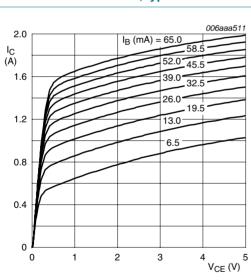
Fig 8. Collector-emitter saturation voltage as a function of collector current; typical values



$$I_{\rm C}/I_{\rm B} = 20$$

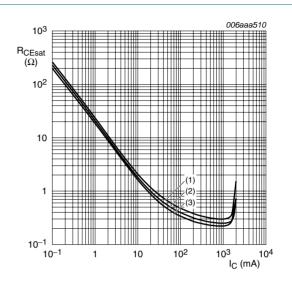
- (1) $T_{amb} = -55 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 9. Base-emitter saturation voltage as a function of collector current; typical values



 $T_{amb} = 25 \, ^{\circ}C$

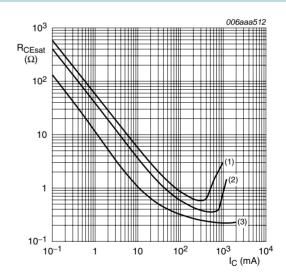
Fig 11. Collector current as a function of collector-emitter voltage; typical values



 $I_{\rm C}/I_{\rm B} = 20$

- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -55 \, ^{\circ}C$

Fig 10. Collector-emitter saturation resistance as a function of collector current; typical values



T_{amb} = 25 °C

- (1) $I_C/I_B = 100$
- (2) $I_C/I_B = 50$
- (3) $I_C/I_B = 10$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

8. Test information

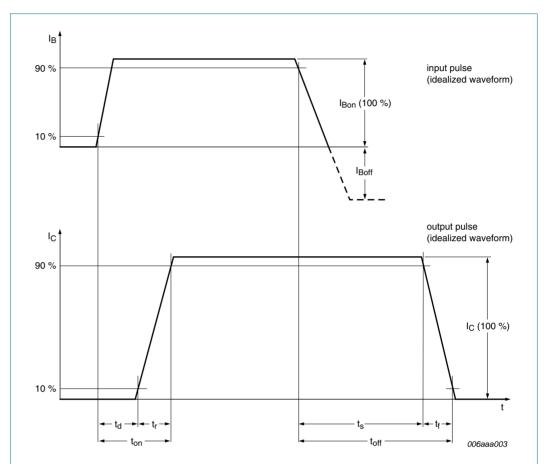
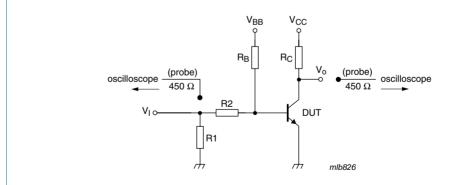


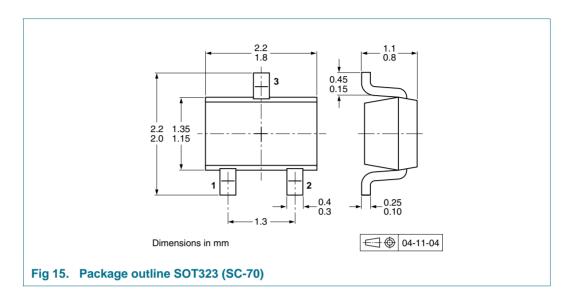
Fig 13. BISS transistor switching time definition



 I_C = 0.5 A; I_{Bon} = 25 mA; I_{Boff} = -25 mA; R1 = open; R2 = 100 Ω ; R_B = 300 Ω ; R_C = 20 Ω

Fig 14. Test circuit for switching times

9. Package outline



10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

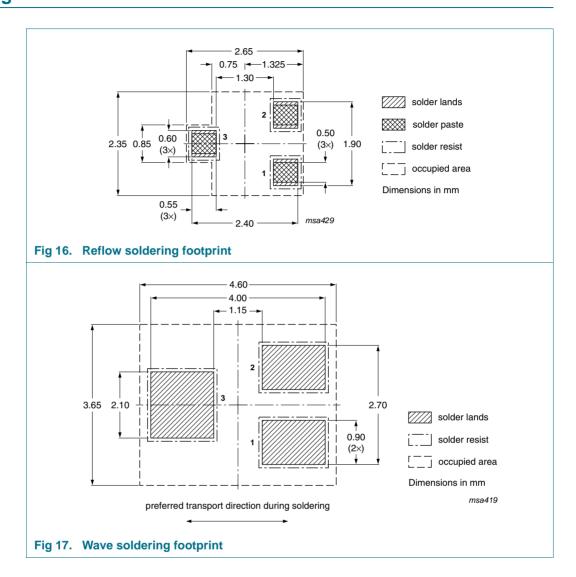
Type number	Package	Description	Packing quantity	
			3000	10000
PBSS4160U	SOT323	4 mm pitch, 8 mm tape and reel	-115	-135

[1] For further information and the availability of packing methods, see Section 14.

NXP Semiconductors PBSS4160U

60 V, 1 A NPN low V_{CEsat} (BISS) transistor

11. Soldering



12. Revision history

Table 9. **Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS4160U_3	20091211	Product data sheet	-	PBSS4160U_2
Modifications:		et was changed to reflect the legal definitions and discla		
	 Figure 16 "Ref 	flow soldering footprint": up	odated	
	Figure 17 "Wa"	ve soldering footprint": upo	lated	
PBSS4160U_2	20050719	Product data sheet	-	PBSS4160U_1
PBSS4160U_1	20040423	Objective data sheet	-	-

NXP Semiconductors PBSS4160U

60 V, 1 A NPN low V_{CEsat} (BISS) transistor

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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NXP Semiconductors

PBSS4160U

60 V, 1 A NPN low V_{CEsat} (BISS) transistor

15. Contents

1	Product profile
1.1	General description
1.2	Features
1.3	Applications
1.4	Quick reference data 1
2	Pinning information 2
3	Ordering information 2
4	Marking 2
5	Limiting values 3
6	Thermal characteristics 4
7	Characteristics 6
8	Test information 9
9	Package outline
10	Packing information 10
11	Soldering 11
12	Revision history
13	Legal information
13.1	Data sheet status
13.2	Definitions
13.3	Disclaimers
13.4	Trademarks
14	Contact information
15	Contents

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